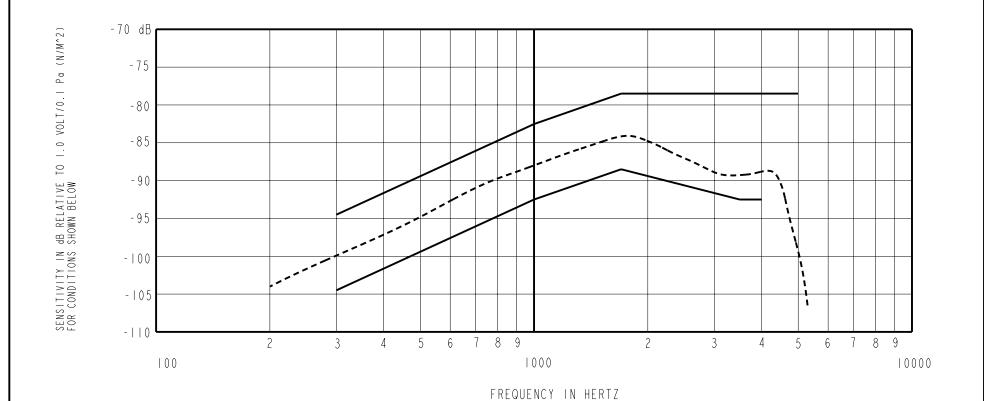
BJ-28411-000 SHT I.I  $7.87 \pm 0.05$  $[.310 \pm .002]$ NOTES: A DECREASE IN PRESSURE AT THE SOUND INLET WILL CAUSE A POSITIVE VOLTAGE AT TERMINAL 2 RELATIVE TO TERMINAL I.  $5,59\pm0,05$ LOCATED FROM TWO SURFACES FOR CUSTOMER [.220 + .0021]CONVENIENCE. ONLY APPLICABLE FROM ONE SURFACE, NOT TO BE USED TOGETHER. -TERMINAL 2 TERMINAL I-(POSITIVE) (NEGATIVE) 0.50  $4.01 \pm 0.05$ > 2,41±0,18 — [.095±.007] [.020]  $[.158 \pm .002]$ -REAR PORT MAXIMUM MAX. SCREEN BUILDUP 0,64 [.025] ---0.50 7.04  $1.60 \pm 0.18$  $1.60 \pm 0.18$ MAXIMUM [.020] [.277] REF.  $[.063 \pm .007]$  $[.063\pm.007]$ SOLDER BUILDUP MAXIMUM SCREEN BUILDUP SCALE 2:1 NOMINAL WEIGHT Revision C.O. # Implementation Date RELEASE LEVEL REVISION .66 GRAM Released DIMENSIONS IN MILLIMETERS [INCHES] C10103470 12-9-05 SCALE: 4: I **KNOWLES ELECTRONICS** CRG 12-9-05 DO NOT SCALE DRAWING CK. BY DATE ITASCA, ILLINOIS U.S.A. TITLE: MICROPHONE BJ-28411-000 GJP 1-5-06 APP. BY DATE SHT I.I OUTLINE DRAWING

1-5-06

WHEN TEST LIMITS ARE USED TO ESTABLISH INCOMING INSPECTION ACCEPTANCE/REJECTION CRITERIA, CORRELATION OF TEST EQUIPMETN WITH KNOWLES IS ALSO REQUIRED FOR ELIMINATION OF EQUIPMENT AND TEST METHOD VARIATIONS.



## NOTES:

- I. LOAD RESISTANCE FOR SENSITIVITY MEASUREMENT: 300 OHMS
- 2. OUTPUT IMPEDANCE AT IKHZ: 300 OHMS NOMINAL
- 3. NOMINAL DC RESISTANCE AT 20°C: 75.5 OHMS
- 4. TESTED WITH REAR PORT OPEN TO LARGE SOUND FREE VOLUME

## 5. <u>SENSITIVITY</u>

<u>FREQUENCY</u>	<u>M   N .</u>	<u>MAX.</u>
300	-104.5	-94.5
1000	-92.5	-82.5
1700	-88.5	-78.5
3500	-92.5	
4000	-92.5	
5000		- 78.5

- 6. FOR EQUAL SPL APPLIED TO FRONT AND REAR PORTS IN PHASE AT 1000 Hz THE SENSITIVTY WILL REDUCE BY AT LEAST 10 dB.
- 7. FOR EQUAL SPL APPLIED TO FRONT AND REAR PORTS IN PHASE AT 1000Hz THE SENSITIVITY WILL REDUCE BY AT LEAST 10 dB.
- 8. FRONT PORT LOCATION: ON REAR PORT LOCATION: 12N

	Revision	C.O. #	Implementation Date	RELEASE LEVEL	REVISION
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DATE
12-9-05

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DATE

1-5-06

KNOWLES ELECTRONICS ITASCA, ILLINOIS U.S.A.

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ELIMINATION OF EQUIPMENT AND TEST METHOD VARIATION

TITLE:

MICROPHONE

PERFORMANCE SPECIFICATION

SHT

GJP

APP. BY

GJP

GJP

APP. BY

GJP